			SHE	EET 1 OF
FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE,	ATTY. DOCKET NO. BROADRE.23CP1C2	APPLICATION NO. 10/621,004	
	DISCLOSURE STATEMENT	10000000		-
/LISE SEL/EDA	L SHEETS IF NEESSARY)	APPLICANT Broadley et al.		
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•	U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)	
18FB	1	2,595,042	04/29/52	Wyllie	204	435		
RFB	2	3,445,368	05/20/69	M. Detemple	204	435		
BFB.	3	3,528,904	09/15/70	Cliffgard	204	468		
BFB	4	3,607,702	09/21/71	Haller	204	435		
BFB	5	3,758,936	09/04/73	Neuwelt	264	435		
PSFB	6	3,915,829	10/28/75	Krebs	204	1958		
PSFB	7	3,917,523	11/04/75	Stein et al.	204	1958		
P8FB	8	3,926,765	12/16/75	Haddad	204	195F		
BFB	9	4,002,547	01/11/77	Neti et al.	204	435		
BFB	10	4,012,308	03/15/77	Jerrold-Jones et al.	204	416		
BFB	11	4,177,126	12/04/79	lmaki et al.	204	435		
BFB	12	4,366,040	12/28/82	Marsoner et al.	204	435		
BFB	13	4,495,052	01/22/85	Brezinski	204	435		
BAB	14	4,592,823	06/03/86	Gregory	204	409		
BFB ·	15	4,592,824	06/03/86	Smith et al.	204	416		
BFB	16	4,818,366	04/04/89	Yonco et al.	204	435		
SFS	17	5,360,529	11/01/94	Edwards et al.	204	435		
BFB	18	5,397,452	03/14/95	Buck et al.	204	435		
BFB	19	5,632,876	05/23/97	Zanzucchih et al.	204	600		
	20	6,165,336	12/26/00	Maki et al.	204	415		

EXAMINER	Brue Beel	DATE CONSIDERED	11/2/04					
SEVAMINED. INITIAL IS CITATION CONCERNED.								

*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.

				SHEET 2 OF
FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY, DOCKET NO. BROADRE,23CP1C2	APPLICATION NO. 10/621,004	*
INFORMATION (INFORMATION DISCLOSURE STATEMENT			
BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY)		APPLICANT Broadley et al.		
		FILING DATE July 15, 2003	GROUP 1746	

				FOREIGN PATENT DOCUMENTS				-	
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANS	TRANSLATION	
	$\bot \bot$						YES	NO	
BYB	21	WO 99/56954	11/11/99	PCT	—	_			
BFB	22	WO 99/63334 A1	12/09/99	РСТ	1	_			
BFB	23	WO 01/75430 A2	10/11/01	PCT					
BFB	24	GB 2 093 193 A	08/25/82	UK					
BFB	25	JP 10104193-A2	04/24/98	JAPAN			х		
BFB	26	JP 11258197-A2	09/24/99	JAPAN			х		
BFB	27	2 541 4624	02/17/83	FRANCE			×		

EXAMINER INITIAL		OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)
BFB	28	Brezinski, Donald, Kinetic, static and stirring errors of liquid junction reference electrodes, Corning Glass Works, April 1983: Vol 108, No. 1285, pp 425-442
BFB	29	Illingworth, John, A common source of error in pH measurements Biochem. J. (1981) 195,259-262
BFB	30	Covington et al., Improvements in the precision of Ph measurements a laboratory reference electrode with renewable free-diffusion liquid junction, Analytica Chemical Acta, 169(1985) 221-229
BFB	31	Dohner et al., Reference electrode with free-flowing free-diffusion liquid junction, Analytical Chemistry, Vol 68, No. 12 (1986) pp 2585-2589
BFB	32	Nishizawa, M. et al.: Metal nanotubule membranes with electrochemically switchable ion-transport selectivity; Science, American Assoc for the advancement of science: 268, 700-702 (1995)
BIB	33	Peters, G.: A reference electrode with free-diffusion liquid junction for electrochemical measurements under changing pressure conditions; Analytical Chemistry, US American Chemical Society: 69:13 2362-2366 (1997)
BFB	34	Suzuki et al., "Microfabricated Liquid Junction Ag/AgC1 Reference Electrode and its Application to a One-Chip Potentiometric Sensor, Anal. Chem. Vol. 71, No. 22, pp. 5089-5075, November 15, 1999
BFB	35	Hulteen, J.C. et al. (1997) A general template-based method for the preparation of nanomaterials. J. Matr. Chem. 7(7):1075-1087.

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